

# Thermal Model and Control of Metal-Organic Chemical Vapor Deposition Process

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# Multi-Quantum Well Light Emitting Diodes (MQW-LED)



S.M. Sze and Kwok K. Ng, LEDs and Lasers, John Wiley & Sons, Inc., 2006.

R. Stevenson, "The LED's Dark Secret," *IEEE Spectrum*, August 2009.

- LEDs used in lighting are Multiple Quantum Well (MQW) devices that are fabricated on sapphire or silicon substrates.
- Several Indium Gallium Nitride (InGaN) quantum wells sandwiched between Gallium Nitride (GaN) quantum barrier layers.
- □ Frequency (color) of emitted light may be tuned from violet to amber by varying relative In/Ga fraction.
- After deposition, wafer diced into small rectangular chips (die), wire bonds (or other electrical leads) are inserted. Phosphor added as suspension or coating for white LEDs.

# Metal-Organic Chemical Vapor Deposition (MOCVD) of LEDs



- Wafers (2"-6" diameter) rest in pockets in graphite susceptor (carrier) heated from below.
- Hydrogen carrier gas inflow through showerhead with dilute mixture of metal organic precursors, Tri-Methyl Gallium (TMG) and Tri-Methyl Indium (TMI) at 50-500 torr.
- Reactive gases decompose and deposit thin epitaxial layers (thicknesses range from a few nm to a few μm).

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### **Cause of Color Variation in LEDs, LED 'binning'**



W. E. Quinn, *Driving Down HB-LED Costs*, Final Technical Report in fulfillment of the requirements of Department of Energy Grant DE-EE0003252, 2012.



W. E. Quinn, "Trends in Production Scale MOCVD Systems to Reduce the Cost of Solid State Lighting," Presentation at Semicon West, 2010.

- Process variations have significant impact on color, lumens, and forward voltage of LEDs.
- Color of light emitted by LED is a strong function of the wafer temperature during deposition.
- Despite excellent control of susceptor temperature, light color varies significantly for chips fabricated on same wafer.
- **To address this problem, LED manufacturers group devices into "bins".**
- Each bin spans a range of color temperature, voltage or lumens. Larger bin size means greater variation in light color or output smaller bins have tighter control.
- For continued rapid increase of LED's share of lighting market, it is necessary to significantly reduce, and preferably eliminate, the need for binning LEDs.

### What Causes Temperature Variation Across Wafer?



#### Using this COMSOL model, we show:

- Temperature gradient through wafer thickness causes wafer to bow (edge high).
- Wafer bow causes carrier/wafer gap to vary with radius from center of wafer.
- □ Variable gap size causes in-plane, radial temperature gradient.

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### Aixtron (Thomas Swan) 3 x 2" Reactor

**3D COMSOL** model of one-third of the relevant part of the reactor was developed taking advantage of azimuthal symmetry.



## **COMSOL** Model

- Heat Transfer (with Surface-to-surface Radiation) and Solid Mechanics modules were used. Effect of flow modeled with correlation as explained in next slide.
- Mesh convergence tested for wafer temperature. Coarse mesh used in regions with low temperature gradients.
- Thermal contact between 2" wafer and susceptor modeled as H<sub>2</sub> layer with an additional thin layer bow of 26 μm depth.
- Operating conditions:
  - 800°C nominal wafer temperature.
  - Pressure of 500 Torr.
  - Susceptor rotation rate of 500 RPM.
- FEM model has 81.3K elements, and 135K DoF. Solution time is about an hour.

Surface: Temperature (degC), and Mesh





### **Correlation for Convective Cooling of Susceptor and Wafer**

- Gas flow not solved here because sufficient mesh refinement for flow increase surface number in surface-to-surface radiation which, in turn, greatly increases computation time.
- Instead, a separate 2D axisymmetric COMSOL model was used to develop heat transfer correlations for stagnation flow heat transfer from a rotating susceptor over a range of operating conditions as shown below.
- □ The resulting correlation for heat transfer coefficient as function of temperature was used in the COMSOL model.

$$h = kA(T) \sqrt{\frac{\rho\omega}{\mu}} \qquad A(T) = (0.29815 + T^*8E-5), \text{ where } T \text{ is in } K$$
  
25 500°C: Nu=0.36 Re<sup>1/2</sup> 750°C: Nu=0.38 Re<sup>1/2</sup> 1000°C: Nu=0.40 Re<sup>1/2</sup>
  
26 500°C: Nu=0.36 Re<sup>1/2</sup> 750°C: Nu=0.38 Re<sup>1/2</sup> 1000°C: Nu=0.40 Re<sup>1/2</sup>
  
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28 500°C: Nu=0.36 Re<sup>1/2</sup> 750°C: Nu=0.38 Re<sup>1/2</sup> 1000°C: Nu=0.40 Re<sup>1/2</sup>
  
29 500°C: Nu=0.36 Re<sup>1/2</sup> 750°C: Nu=0.38 Re<sup>1/2</sup> 1000°C: Nu=0.40 Re<sup>1/2</sup>
  
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20 8 density
  
20 8 rotation rate, rad/s
  
20 8 Re susceptor radius
  
20 8 rotation rate, rad/s
  
20 8 Re<sup>1/2</sup> Nu Low FFM 1000C Med alm vary per H 1000C Med alm vary per H 100°C Med alm vary per H 10°C Med alm vary

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Re (based on properties at susceptor surface T)

Nu (at susceptor surface T)

### **Heaters**

- 7 heater coils grouped into 3 zones (Zone 1: innermost two coils, Zone 2: middle 4, and Zone 3: outermost coil).
- **Each power zone coils vertically separated by ceramic plates.**
- Baseline powers are : 48 W, 199 W, 823 W (divided among coils proportionate to coil volume).





#### **Susceptor Temperatures**

- Heated by radiation (and some conduction through nitrogen) from heaters.
- Loses heat radiatively to the surroundings walls and by convection to the process gases (modeled using heat transfer coefficient correlation).
- Maximum susceptor temperature is about 1025°C.



Surface: Temperature (degC), and Mesh

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### Wafer Bow

- Lower wafer surface is about 3°C hotter than top.
- **Resulting differential thermal expansion results in concave bow.**
- **This bow leads to the wafer top surface temperature non-uniformity.**



Vertical axis magnified for clarity.

#### **Wafer Temperature Gains**

#### Gains computed for each zone (units of °C/W).







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### **Best Wafer Temperature Uniformity**

Temperature range with optimal power settings is less than 4°C on wafer top.
 Azimuthal asymmetry in wafer temperature non-uniformity cannot be corrected by heater power adjustments.



z dimension scaled up by factor of five.

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#### **Temperature Binning**

- Mesh in COMSOL model specifies temperatures at 618 points on top of wafer.
- These temperatures were binned into 7 bins that are 1°C in width.
- The challenge is to reduce the number of bins to one or two, i.e., within-wafer temperature nonuniformity to within 2°C or less.



## **Summary and Acknowledgement**

- COMSOL thermal model of MOCVD confirms that wafer bowing contributes substantially to within-wafer temperature nonuniformity.
- In the next step, we will validate model with experimental data.

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